

Search Notes

Application/Control No.

10/799,167

Examiner

John T. Kwon

Applicant(s)/Patent under
Reexamination

GEYER ET AL.

Art Unit

3747

SEARCHED

Class	Subclass	Date	Examiner
123	73PP	7/22/2005	JK
	195C		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	7/22/2005	JK